

**Search Notes**

Application/Control No.

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Applicant(s)/Patent under  
Reexamination

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Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
updated	search	6/23/2005	PTC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR